IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of	Group Art Unit: Examiner:			
Michael J. DeBar, et al				
MEASURING ABSOLUTE STATIC PRESSURE AT ONE OR MORE POSITIONS ALONG A MICROFLUIDIC DEVICE	Express Mail Label No. EV293538387US 8-25.03 Date			
Serial No. To Be Assigned				
Filed Herewith				
Commissioner for Patents P.O. Box 1450 Alexandria, VA. 22313-1450				
Sir:				
	STATEMENT FOR CONSIDERATION			
BY THE OFFICE U	NDER 37 C.F.R. 1.97-1.99			
Enclosed herewith are p by the Patent and Trademark Office in above-described application. In composite listed in the enclosed Form PTO-1449	liance with §1.56, such documents are			
record the above-identified documents	vailable, a concise explanation of the			
This Information Disclosubmitted according to the following se	osure Statement (hereinafter "Statement") is elected paragraph:			
the filing date of the application mailing of a first Office act	ed under §1.97(b) within three months of ation (other than a CPA), or before the ion on the merits or before the mailing of a filing of a request for continued			
mailing date of any of a finate that otherwise closes prosect fee required by §1.17(p) to	d under §1.97(c), with fee, prior to the al action, a notice of allowance or an action cution in the application. Please charge the Eastman Kodak Company Deposit Order A duplicate copy of this Certification is			

III.	This Statement is being filed under §1.97(c), with a certification under, §1.97(e) prior to the mailing date of any of a final action, a notice of allowance or an action that otherwise closes prosecution in the application. The undersigned hereby states that (check one):					
	each item of information contained in this Statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this Statement.					
	no item of information in this Statement was cited in a communication from a foreign patent office in a counterpart foreign application, and, to the knowledge of the person signing this certification under §1.97(e) after making reasonable inquiry, no item of information contained in this Statement was known to any individual designated in §1.56(c) more than three months prior to the filing of this Statement.					
IV.	This Statement is being filed under §1.97(d), with fee and certification under §1.97(e), on or after the mailing date of either a final action, a notice of allowance (but prior to payment of the issue fee) or an action that otherwise closes prosecution in the application. Please charge the fee required by §1.17(p) to Eastman Kodak Company Deposit Order Account No. 05-0225. A duplicate copy of this Certification is enclosed. The undersigned hereby states that (check one):					
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[no item of information in this Statement was cited in a communication from a foreign patent office in a counterpart foreign application, and, to the knowledge of the person signing this certification under §1.97(e) after making reasonable inquiry, no item of information contained in this Statement was known to any individual designated in §1.56(c) more than three months prior to the filing of this Statement.					

Raymond L. Owens/das Telephone: 585-477-4653 Facsimile: 585-477-4646

Enclosures

Attorney for Applicants Registration No. 22,363

Respectfully submitted,

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